

# Abstracts

## M)MIC Analysis Using a Hierarchy of Simulation Tools Controlled by Layout Pattern Recognition and Expert Knowledge

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*S. Tadjiky and R.H. Jansen. "M)MIC Analysis Using a Hierarchy of Simulation Tools Controlled by Layout Pattern Recognition and Expert Knowledge." 1996 MTT-S International Microwave Symposium Digest 96.2 (1996 Vol. II [MWSYM]): 741-744.*

An intelligent Design Assistant has been developed connecting the layout input and the netlist level of a CAD system using a hierarchy of different simulation tools. This design utility represents a new approach based on layout pattern recognition and expert knowledge for automated choice and control of the most suitable tools.

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